OIPE CON NELSON

LAW OFFICES

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WASHINGTON, DC
WINSTON-SALEM, NORTH CAROLINA

February 24, 2004

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450 MAR 0 2 2004

In re: Application of Victor Giurgiutiu

Title: "IN-SITU STRUCTURAL HEALTH MONITORING, DIAGNOSTICS

AND PROGNOSTICS SYSTEM UTILIZING THIN PIEZOELECTRIC SENSORS"

Serial No: 10/072,644

Filed: February 8, 2002

Our Ref: 16139/09021

Dear Sir:

The following is being transmitted herewith:

1. Petition to Withdraw the Holding of Abandonment Under 37 C.F.R. § 1.181, with Exhibits A, B, and C

Please charge any deficiency or credit any overpayment required by this action to our deposit account no. 50-1196, for which purpose an extra copy of this transmittal letter is attached.

Very truly yours

Reg. No. 35,218

I hereby certify that this correspondence and any referenced at achment and/or fee are being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the date listed above.

Martha Boynton

(Typed or printed name of person mailing paper or fee)

(Signature of person mailing paper or fee)

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#7/WD from
PATENT abands

ATTORNEY DOCKET NO.: 16139/09021

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

| In Re Application of             | )   |                |
|----------------------------------|-----|----------------|
| VICTOR GIURGIUTIU                | )   | Examiner:      |
|                                  | )   | Shah, Kamini S |
| Serial No.: 10/072,644           | ) . |                |
|                                  | )   | Art Unit: 2863 |
| Filed: February 8, 2002          | )   |                |
|                                  | )   |                |
| Title: IN-SITU STRUCTURAL HEALTH | )   |                |
| MONITORING, DIAGNOSTICS AND      | )   |                |
| PROGNOSTICS SYSTEM UTILIZING     | )   |                |
| THIN PIEZOELECTRIC SENSORS       | )   |                |
|                                  |     |                |

# PETITION TO WITHDRAW THE HOLDING OF ABANDONMENT UNDER 37 C.F.R. § 1.181

Mail Stop Petitions Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

This is in response to a Notice of Abandonment mailed

September 9, 2003 in relation to the above-identified application.

A copy of the Notice of Abandonment is attached hereto at Exhibit

A.

The Notice of Abandonment was based on Applicant's alleged failure to respond to the Office Action mailed on March 5, 2003. The Office Action set a shortened statutory period for reply three months from its mailing date. Thus, the period for response to the Office Action expired on June 5, 2003, but was extendable through September 5, 2003 with the payment of the fee for a three-month extension of time.

In fact, Applicant mailed a proper response to the Office

Action on September 4, 2003, with payment of the fee for a three-month extension. A copy of the response and all related documents is attached hereto at Exhibit B. The reply included a Certificate of Mailing pursuant to 37 C.F.R. § 1.8.

Applicant's amendment was received by the PTO Mail Room on September 8, 2003, as shown by the self-addressed postcard stamped by the PTO Mail Room on that date. A copy of the postcard is attached hereto at Exhibit C.

In view of the foregoing, it is respectfully requested that the holding of abandonment be withdrawn, that the application be reinstated to good standing, and that the application now proceed to further substantive examination by the PTO.

Please charge any deficiency or credit any overpayment required by this action to our deposit account no. 50-1196.

Respectfully submitted,

NELSON MULLINS, RILEY & SCARBOROUGH

Cruig N. Killen

Registration No. 35,218

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I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail under 37 CFR 1.8 and is addressed to: Mail Stop Petitions, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on February 24, 2004.

Martha Boynton

Typed or printed name of person mailing paper or fee

Signature of person mailing paper or fee



# United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE
COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, Virginia 22313-1450

| APPLICATION NO.                                 | FIL   | ING DATE         |     | FIRST NAMED INVENTOR  | ATT  | ORNEY DOCKET NO.   | CONFIRMATION NO |
|---|-------|------------------|-----|-----------------------|------|--------------------|-----------------|
| 10/072,644                                      | 0     | 2/08/2002 .      |     | Victor Giurgiutiu     |      | 16139/09021        |                 |
| . 7   | 590   | 09/09/2003       | ?   |                       |      |                    |                 |
| Lloyd G. Fari                                   |       | •                | - { |                       |      | EXAMI              | NER             |
| Nelson Mulling<br>P.O. Box 1107<br>Columbia, SC | 0     | z Scarborough, I | LLP |                       |      | SHAH, KA           | AMINI S         |
| Columbia, 5C                                    | 27211 |                  |     | MAD                   |      | ART UNIT           | PAPER NUMBER    |
|   |       | •                |     | MAR 0 2 2004          |      | 2863               |                 |
|   |       |                  |     |                       | DATE | MAILED: 09/09/2003 |                 |
|   |       | . į              | ,   | or the same transport |      |                    |                 |

Please find below and/or attached an Office communication concerning this application or proceeding.



SEP 1 1 2003

NELSON MULLINS COLUMBIA OFFICE

Pet. to Rruve Dockered or 09 No 03

|   | Application No.                    | Applicant(s)   |                  |
|---|------------------------------------|--|------------------|
| Madter of Microsoft Co.   | 10/072,644                         | GIURGIUTIU, VICT   | OR               |
| Notice of Abandonment   | Examiner                           | Art Unit   | <u> </u>         |
|   | Kamini S Shah                      | 2863   |                  |
| The MAILING DATE of this communication a  |                                    |  | <br>SS           |
| This application is abandoned in view of:   | ,,                                 |  |                  |
|   |                                    | ·  |                  |
| <ol> <li>Applicant's failure to timely file a proper reply to the Office (a) A reply was received on (with a Certificate of period for reply (including a total extension of time)</li> </ol> | of Mailing or Transmission dated   | ), which is after the exp  | iration of the   |
| (b) ☐ A proposed reply was received on, but it do   | es not constitute a proper reply ι | under 37 CFR 1.113 (a) to the t                                    | final rejection. |
| (A proper reply under 37 CFR 1.113 to a final rejection application in condition for allowance; (2) a timely for allowance with 3 continued Examination (RCE) in compliance with 3            | iled Notice of Appeal (with appea  | filed amendment which places<br>al fee); or (3) a timely filed Req | the<br>uest for  |
| (c) ☐ A reply was received on but it does not confinal rejection. See 37 CFR 1.85(a) and 1.111. (See  |                                    | ide attempt at a proper reply, to                                  | o the non-       |
| (d) ⊠ No reply has been received.   |                                    |  |                  |
| Applicant's failure to timely pay the required issue fee from the mailing date of the Notice of Allowance (PTO)   |                                    | , within the statutory period of t                                 | three months     |
| (a) ☐ The issue fee and publication fee, if applicable, v<br>), which is after the expiration of the statutory<br>Allowance (PTOL-85).  |                                    |  |                  |
| (b) ☐ The submitted fee of \$ is insufficient. A bala   | nce of \$ is due.                  |  |                  |
| The issue fee required by 37 CFR 1.18 is \$   | . The publication fee, if required | d by 37 CFR 1.18(d), is \$   | <u>.</u>         |
| (c) $\square$ The issue fee and publication fee, if applicable, has   | s not been received.               | ·  |                  |
| Applicant's failure to timely file corrected drawings as reAllowability (PTO-37).   | equired by, and within the three-  | month period set in, the Notice                                    | of               |
| (a) Proposed corrected drawings were received onafter the expiration of the period for reply.   | (with a Certificate of Mailing     | or Transmission dated)   | , which is       |
| (b) No corrected drawings have been received.   |                                    |  |                  |
| <ol> <li>The letter of express abandonment which is signed by<br/>the applicants.</li> </ol>  | the attorney or agent of record,   | the assignee of the entire inter                                   | est, or all of   |
| <ol> <li>The letter of express abandonment which is signed by<br/>1.34(a)) upon the filing of a continuing application.</li> </ol>  | an attorney or agent (acting in a  | representative capacity under                                      | 37 CFR           |
| 6. The decision by the Board of Patent Appeals and Inter of the decision has expired and there are no allowed c   |                                    | because the period for seeking                                     | court review     |
| 7. The reason(s) below:   |                                    |  |                  |
|   |                                    |  |                  |
|   |                                    | Sum S<br>Kamini S Shah   | ٩                |
|   |                                    | Primary Examiner<br>Art Unit: 2863                                 |                  |
| Petitions to revive under 37 CFR 1.137(a) or (b), or requests to with minimize any negative effects on patent term.   | draw the holding of abandonment ur |  | nptly filed to   |
| S. Patent and Trademark Office TOL-1432 (Rev. 04-01) Notic  | e of Abandonment                   | Part o   | f Paper No. 6    |
|   |                                    |  |                  |



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WINSTON-SALEM, NORTH CAROLINA

September 4, 2003

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

In re: Application of Victor Giurgiutiu

Title: "IN-SITU STRUCTURAL HEALTH MONITORING, DIAGNOSTICS

AND PROGNOSTICS SYSTEM UTILIZING THIN PIEZOELECTRIC

SENSORS"

Serial No: 10/072,644

Filed: February 8, 2002

Our Ref: 16139/09021

Dear Sir:

The following are being transmitted herewith:

1. Amendment, 12 pages

- 2. 10 sheets of formal drawings, Figures 1-12
- 3. Fee Transmittal for FY 2003
- 4. Check in the amount of \$588.00

Please charge any deficiency or credit any overpayment required by this action to our deposit account no. 50-1196, for which purpose an extra copy of this transmittal letter is attached.

Very truly your

Reg. No/35,218

I hereby certify that this correspondence and any referenced attachment and/or fee are being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on the date listed above.

Martha Boynton

(Typed or printed name of person mailing paper or fee)

(Signature of person mailing paper or fee)

PTC/SB/17;(01-03)

Approved for use through 04/30/2003. OMB 6651-0032

U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

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# FEE TRANSMITTAL for FY 2003

Effective 01/01/2003. Patent fees are subject to annual revision.

Applicant claims small entity status. See 37 CFR 1.27

TOTAL AMOUNT OF PAYMENT

| (\$) | 588 |
|------|-----|
|      |     |

| Co                   | omplete if Known    |
|----------------------|---------------------|
| Application Number   | 10/072,644          |
| Filing Date          | February 8, 2002    |
| First Named Inventor | Victor Giurgiutiu 0 |
| Examiner Name        | Shah, Kamini S. ?   |
| Art Unit             | 2863                |
| Attorney Docket No.  | 16139/09021         |

| METHOD OF PAYMENT (check all that apply)  |                              | FEE CALCULATION (continued)  |            |
|---|------------------------------|--|------------|
| XX Check Credit card Money Other None   | 3. ADDITION                  | IAL FEES .   |            |
| XX Deposit Account  | arge Entity   Sn             | mall Entity  | · with the |
| Deposit   | Fee Fee Fee<br>Code (\$) Cod | e Fee Fee Description  | ee Paid    |
| Account 50-1196   | 1051 130 205                 | The state of the s | Falu       |
| Deposit Nelson Mullins Riley  | 1052 50 205                  |  |            |
| Account & Scarborough   | 1053 130 105                 | cover sheet 53 130 Non-English specification   |            |
| The Commissioner is authorized to: (check all that apply)   | 1812 2.520 181               |  |            |
| Charge fee(s) indicated below XX Credit any overpayments  |                              | 304 920* Requesting publication of SIR prior to  | ·          |
| Charge any additional fee(s) during the pendency of this application                              |                              | Examiner action —  |            |
| Charge fee(s) indicated below, except for the filing fee to the above-identified deposit account. | 1805 1,840 180               | 05 1,840* Requesting publication of SIR after Examiner action  |            |
| FEE CALCULATION   | 1251 110 22                  | 251 55 Extension for reply within first month  |            |
| 1. BASIC FILING FEE   | 1252 410 22                  | 252 205 Extension for reply within second month  |            |
| Large Entity Small Entity   | 1253 930 22                  | 253 465 Extension for reply within third month   | 465        |
| Fee Fee Fee Fee Fee Description Fee Paid Code (\$) Code (\$)                                      | 1254 1,450 22                | 54 725 Extension for reply within fourth month   |            |
| 1001 750 2001 375 Utility filing fee  | 1255 1,970 22                | 55 985 Extension for reply within fifth month  |            |
| 1002 -330 2002 165 Design filing fee  | 1401 320 24                  | 401 160 Notice of Appeal .   |            |
| 1003 520 2003 260 Plant filing fee  | 1402 320 24                  | 402 160 Filing a brief in support of an appeal   |            |
| 1004 750 2004 375 Reissue filing fee  | 1403 280 24                  | 403 140 Request for oral hearing   |            |
| 1005 160 2005 80 Provisional filing fee   | 1451 1,510 14                | 51 1,510 Petition to institute a public use proceeding   |            |
| SUBTOTAL (1) (\$)   | 1452 110 24                  | 452 55 Petition to revive - unavoidable  |            |
| 2. EXTRA CLAIM FEES FOR UTILITY AND REISSUE   | 1453 1,300 24                | 53 650 Petition to revive - unintentional  |            |
| Fee from  | 1501 1,300 250               |  |            |
| Extra Claims below Fee Paid  Total Claims 29 -20** = 9 X 9 = 81                                   |                              | 502 235 Design issue fee   |            |
| Independent 4 2 1 42  |                              | 503 315 Plant issue fee  |            |
| Claims -3" = 1  |                              | 460 130 Petitions to the Commissioner  |            |
| Large Entity   Small Entity   |                              | 807 50 Processing fee under 37 CFR 1.17(q)   |            |
| Fee Fee Fee Fee Description   |                              | 806 180 Submission of Information Disclosure Stint  021 40 Recording each patent assignment per  |            |
| Code (\$)   | 8021 40 81                   | property (times number of properties)  |            |
| 1201 84 2201 42 Independent claims in excess of 3   | 1809 750 28                  | 809 375 Filing a submission after final rejection (37 CFR 1.129(a))  |            |
| 1203 280 2203 140 Multiple dependent claim, if not paid   | 1810 750 28                  | 810 375 For each additional invention to be  |            |
| 1204 84 2204 42 ** Reissue independent claims   |                              | examined (37 CFR 1.129(b))   |            |
| over original patent  | 1801 750 280                 |  |            |
| 1205 18 2205 9 ** Reissue claims in excess of 20 and over original patent                         | 1802 900 18                  | 02 900 Request for expedited examination of a design application   |            |
| SUBTOTAL (2) (\$) 123   | Other fee (specify           |  |            |
| **or number previously paid, if greater, For Reissues, see above                                  | Reduced by Bas               | sic Filing Fee Paid SUBTOTAL (3) (\$) .465   |            |

SUBMITTED BY

Name (Print/Type)

Craig N. Killen

Prodstration No. 35,218

Telephone (803) 255-9382

Signature

Date Sept. 4, 2003

WARNING: Information of this form may become public. Credit card information should not be included on this form. Provide credit card information and authorization on PTO-2038.

This collection of information is required by 37 CFR 1.17 and 1.27. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 12 minutes to complete, including gathering, preparing, and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, Washington, DC 20231. DO NOT SEND FEES OR COMPLETED FORMS TO THIS ADDRESS. SEND TO: Commissioner for Patents, Washington, DC 20231.



PATENT ATTORNEY DOCKET NO.: 16139/09021

Examiner:

Shah, Kamini S

Art Unit 2863

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re Application of VICTOR GIURGIUTIU

Serial No.: 10/072,644

Filed: February 8, 2002

For: IN-SITU STRUCTURAL HEALTH

MONITORING, DIAGNOSTICS AND PROGNOSTICS SYSTEM UTILIZING THIN PIEZOELECTRIC SENSORS

314771473

AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the Office Action mailed March 5, 2003, please amend the above-identified application as follows:

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Claims are reflected in the listing of claims which begins on page 3 of this paper.

Amendments to the Drawings begin on page 8 of this paper and include a full set of replacement sheets intended to be the formal drawings for this application.

Remarks begin on page 9 of this paper.

#### Amendments to the Specification:

Please replace the paragraph at page 15, line 16 through page 16, line 8 with the following amended paragraph:

The examples provided above, i.e., impedance sensing and ultrasonic sensing, rely on active sensors to measure structural characteristics. The present invention may also, however, be used in passive modes to detect structural damage. In certain of there these embodiments, a plurality of sensors is disposed in a predetermined orientation relative to each other and at known positions on the structure. The sensor outputs are monitored intermittently or continuously, even though the sensors may not be engaged in either of the active measurement procedures described above. Damage events may be identified through the reception of stress waves generated in the structure through impacts or other material disruptions. Certain waves may, for example, indicate an occurrence of a low-velocity impact. The sensor may also, however, detect acoustic emission signals that indicate damage has occurred. By determining and recording the location and time of damage events, a record may be compiled to predict the structure's remaining operative life.

Please replace the paragraph at page 19, line 17 through page 20, line 4 with the following amended paragraph:

For impedance sensing, an adjustable-voltage-power gain-phase impedance analyzer 46 excites the transducers, which output measurement information back to analyzer 46. Analyzer 46 includes software algorithms algorithms to analyze the sensor data to determine the locations and orientation of damage features as described above. Alternatively, analyzer 46 may forward the data to computer 38 for analysis. Generally, computer 38 houses the system's software components, the operation of which is generally described above and which may include non-destructive evaluation and imaging software package 48, monitoring diagnostics and analysis software package 52 and/or artificial intelligence, neural-network and data mining software 54.

#### Amendments to the claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

#### Listing of claims:

Claims 1-2 (cancelled)

Claim 3 (new): A system operative to detect a damage feature in a thin wall structure, said system comprising:

an array of piezoelectric wafer sensors embedded on said structure in a predetermined pattern;

a generator operative to excite at least one of said sensors to produce ultrasonic waves having a frequency of at least about 200 KHz in said structure; and

a signal processor operative to process received signals at least two of said sensors so as to detect said damage feature.

Claim 4 (new): A system as set forth in claim 3, wherein said generator is operative to excite each of said sensors in said array in round-robin fashion.

Claim 5 (new): A system as set forth in claim 4, wherein said signal processor is operative to determine a location of said damage feature based on a collection of data representing received signals at a plurality of said sensors after round-robin excitation of all of said sensors in said array.

Claim 6 (new): A system as set forth in claim 4, wherein said array comprises at least four of said sensors.

Claim 7 (new): A system as set forth in claim 3, wherein said frequency of said ultrasonic waves include a significant component at approximately 300 KHz.

Claim 8 (new): A system as set forth in claim 7, wherein said ultrasonic waves are Lamb waves.

Claim 9 (new): A system as set forth in claim 3, wherein said frequency of said ultrasonic waves falls in the megahertz range.

Claim 10 (new): A system as set forth in claim 3, wherein said ultrasonic waves are Lamb waves.

Claim 11 (new): A system as set forth in claim 10, wherein said sensors are adhered to a surface of said thin wall structure.

Claim 12 (new): A system as set forth in claim 3, wherein said wafer sensors have a planar surface area no greater than approximately 169 mm<sup>2</sup> and a thickness no greater than approximately 0.49 mm.

Claim 13 (new): A system as set forth in claim 12, wherein said wafer sensors are generally rectangular.

Claim 14 (new): A system operative to detect a damage feature in a structure, said system comprising:

an array of piezoelectric wafer active sensors embedded on said structure in a predetermined pattern, said wafer sensors having a planar surface area no greater than approximately 169 mm<sup>2</sup> and a thickness no greater than approximately 0.49 mm;

a generator operative to excite each of sensors in said

array in round-robin fashion to produce ultrasonic waves in said structure; and

a signal processor operative to process received signals at least two of said sensors so as to detect said damage feature.

Claim 15 (new): A system as set forth in claim 14, wherein said signal processor is operative to determine a location of said damage feature based on a collection of data representing received signals at a plurality of said sensors after round-robin excitation of all of said sensors in said array.

Claim 16 (new): A system as set forth in claim 14, wherein said array comprises at least four of said sensors.

Claim 17 (new): A system as set forth in claim 14, wherein said frequency of said ultrasonic waves falls in a range of 200 kHz to high megahertz.

Claim 18 (new): A system as set forth in claim 17, wherein said frequency of said ultrasonic waves is approximately 300 KHz.

Claim 19 (new): A system as set forth in claim 18, wherein said ultrasonic waves are Lamb waves.

Claim 20 (new): A system as set forth in claim 14, wherein said sensors are adhered to a surface of said thin wall structure.

Claim 21 (new): A method of detecting impact to a structure by a foreign object, said method comprising steps of:

- (a) providing an array of piezoelectric wafer sensors embedded on said structure in a predetermined pattern;
  - (b) simultaneously monitoring said sensors in said array to

detect impact signals caused by stress waves produced in said structure by said foreign object; and

(c) processing a collection of said impact signals so as to ascertain a location of said impact.

Claim 22 (new): A method as set forth in claim 21, wherein said sensors are simultaneously monitored in step (b) on a continuous basis.

Claim 23 (new): A method as set forth in claim 21, wherein said sensors are simultaneously monitored in step (b) on an intermittent basis.

Claim 24 (new): A method as set forth in claim 21, wherein said array comprises at least four of said sensors.

Claim 25 (new): A method as set forth in claim 24, wherein said wafer sensors have a planar surface area no greater than approximately 169 mm<sup>2</sup> and a thickness no greater than approximately 0.49 mm.

Claim 26 (new): A method as set forth in claim 25, wherein said wafer sensors are generally rectangular.

Claim 27 (new): A method as set forth in claim 21, further comprising the following steps:

- (d) exciting at least one of said sensors to produce ultrasonic waves having a frequency of at least 200 KHz in said structure; and
- (e) detecting said ultrasonic waves at said sensors so as to ascertain the presence of damage features in said structure.

Claim 28 (new): A method of detecting a damage feature

present within a predetermined sensing zone in a thin wall structure, said method comprising steps of:

- (a) providing at least one piezoelectric wafer sensor embedded on said structure;
- (b) exciting said sensor with a first electrical signal spanning a predetermined frequency range;
- (c) deriving first data characteristic of a drive-point impedance of said wafer sensor as embedded on said structure;
- (d) exciting said sensor with a second electrical signal spanning said predetermined frequency range;
- (e) deriving second data characteristic of said drive-point impedance of said wafer sensor; and
  - (f) comparing said first data and said second data.

Claim 29 (new): A method as set forth in claim 28, wherein a plurality of said wafer sensors are provided on said structure in an array.

Claim 30 (new): A method as set forth in claim 29, wherein said sensors are arranged in said array so as to have overlapping sensing zones.

Claim 31 (new): A method as set forth in claim 30, wherein said wafer sensors have a planar surface area no greater than approximately 169 mm<sup>2</sup> and a thickness no greater than approximately 0.49 mm.

## Amendments to the Drawings:

The attached set of formal drawings replaces the original informal drawing sheets filed with the present application.

Attachment: Replacement drawing sheets (10 sheets)

#### REMARKS

Favorable reconsideration and allowance of the present application are respectfully requested.

Claims 1-2 were rejected under 35 U.S.C. § 102(b) as being anticipated by U.S. Pat. No. 6,006,163 to <u>Lichtenwalner</u>. By the above amendment, claims 1-2 have been cancelled without prejudice. As such, the rejection of these claims is believed to be moot.

While claims 1-2 have been cancelled, some comments about differences between <u>Lichtenwalner</u> and the subject matter described in the present application are in order. In this regard, <u>Lichtenwalner</u> discloses a system utilizing piezoelectric transducers operating at frequencies up to 100 KHz. Col. 6, line 23 and claim 4. The patent states that transducer signals are digitized and the transfer function (TF) amplitude and phase of each actuator/sensor pair is computed. Col. 4, lines 30-33. The calculated transfer function is then compared against a baseline transfer function for that actuator/sensor pair previously obtained with the structure in an undamaged state. Col. 4, lines 33-37.

After the transfer function comparison, a damage index (DI) for each actuator can be determined. Col. 6, lines 51-54. The actuator with the highest DI is used to identify the damage zone. Col. 6, lines 64-65. Center of mass equations, with appropriate

substitution of the DI values for the point-mass values, are used to determine the location of damage. Col. 7, lines 7-9.

Contrasting the disclosed technique with ultrasonic techniques,

<u>Lichtenwalner</u> states that certain experimental results were validated using "[s]ubsequent ultrasonic inspection." Col. 9, lines 10-11.

The present application, on the other hand, discloses a system utilizing arrays of very small piezoelectric wafer active sensors. In many cases, for example, the length of each wafer will be less than 13mm per side (i.e., 169mm² surface area) and have a thickness of no greater than 0.49mm thick. Both active and passive evaluation techniques can be employed using such an array. For example, true ultrasonic (i.e., 200KHz and above) elastic waves can be propagated through a thin wall structure using the sensors. Sensors can be actuated in round robin fashion with detection at all sensors in the array to produce a rich matrix of information. The matrix can be analyzed using various computational techniques to determine the location of a damage feature in the structure. Advantageously, sensors of this type can directly excite Lamb waves into the structure without the need for mode conversion.

Alternatively, drive point impedance measurements can be taken at each sensor in order to detect changes in a sensing zone around that sensor. In other words, damage in the sensing zone

will cause changes in the drive point impedance of the particular sensor. These changes will be reflected in the sensor's impedance spectrum. As a result, impedance measurements taken before and after occurrence of the damage feature can be utilized to detect its presence. Preferably, sensors in the array are arranged so that their impedance sensing zones will overlap.

Passive detection modes are also contemplated in which the sensor outputs are monitored intermittently or continuously for stress waves in the structure. Stress waves may indicate, for example, that a foreign object has impacted the structure. Triangulation or other suitable techniques may be utilized to determine the impact's position with respect to the sensors.

Claims 3-31 have been added to set forth additional aspects of Applicant's inventive subject matter, many of such aspects being reflected in the above discussion. Of these new claims, claims 3, 14, 21 and 28 are independent claims. Each new claim is fully supported by the application as filed and is believed to be distinguishable over the art of record.

Based on the above, it is respectfully submitted that the present application, including claims 3-31, is in condition for allowance, and action to such effect is earnestly solicited. The Examiner is invited to telephone the undersigned should any minor issues remain after consideration of the above amendment.

Respectfully submitted,

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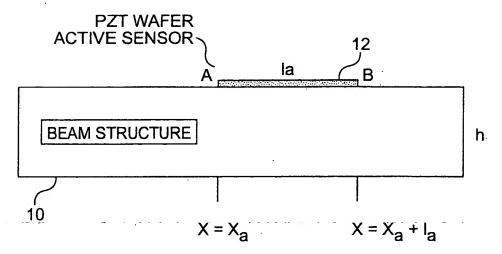


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MAR 0 2 2004



PZT STRAIN AND DISPLACEMENT,  $\epsilon_{PZT}$  AND  $U_{PZT}$ 

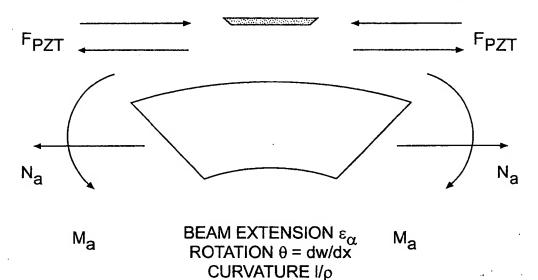


FIG. 1

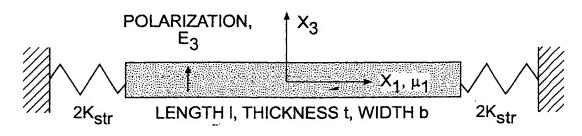


FIG. 2



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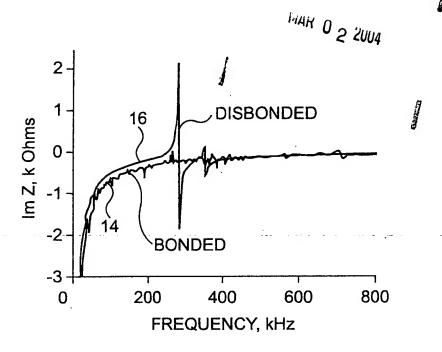


FIG. 3

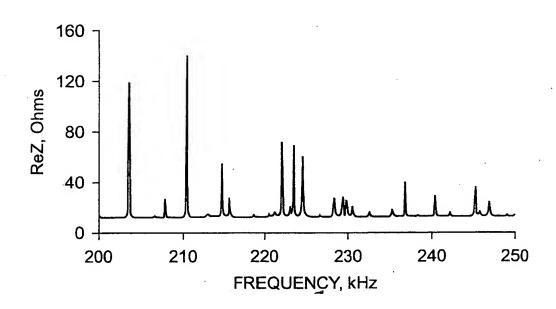


FIG. 4

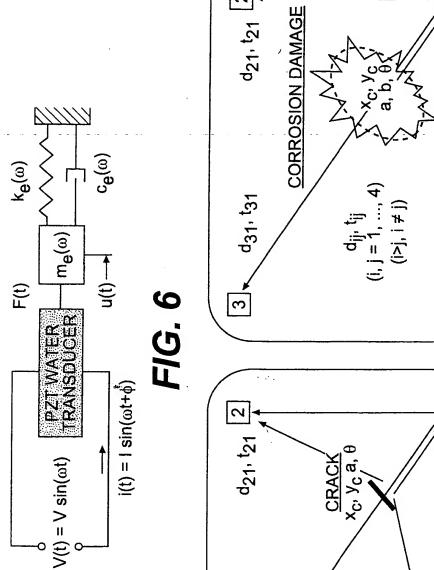
Application of Victor Giurgiutiu Serial No: 10/072,644 Examiner: Shah, Kamini S. Art Unit: 2863 THE TRADEMARY FEB 2 8 2004 2 FIG. 5b <u>8</u> 3 4 2 -STRUCTU 3



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F/G. 7b

FIG. 7a

d41, t41

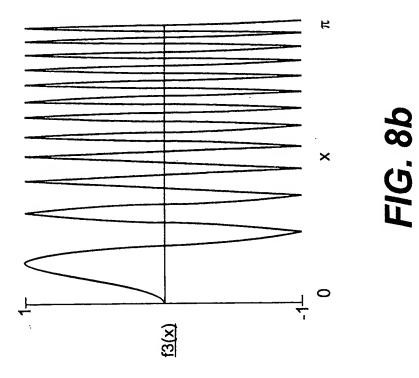
(i>j, i ≠ j)

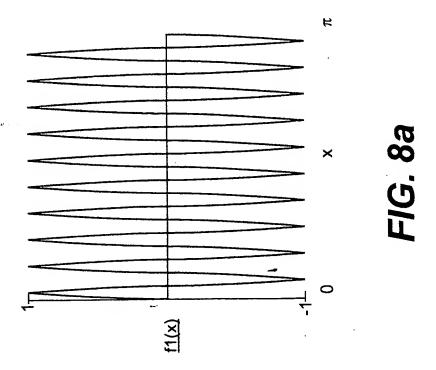
d41, t41

4



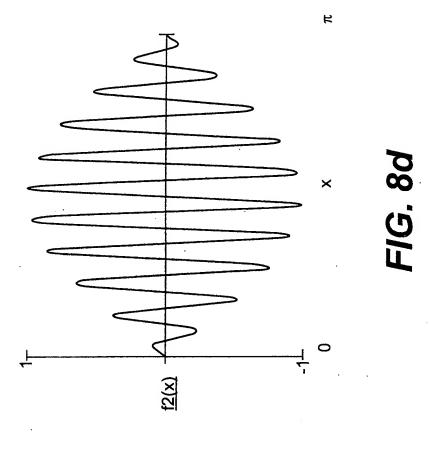
Application of Victor Giurgiutiu Serial No: 10/072,644 Examiner: Shah, Kamini S. Art Unit: 2863

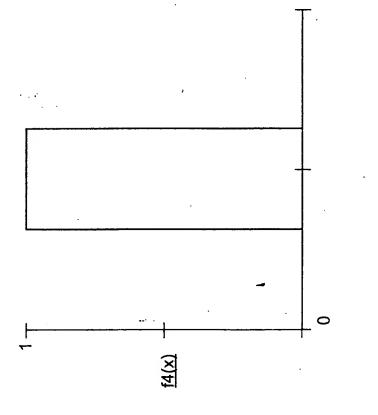






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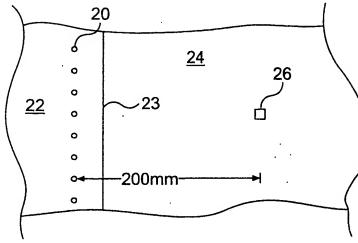


FIG. 9a

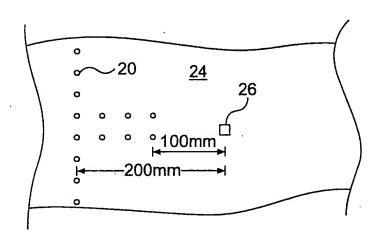


FIG. 9b

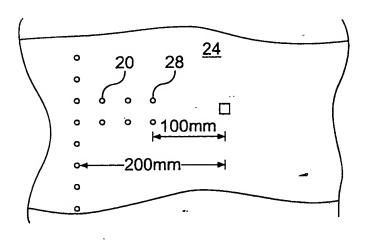
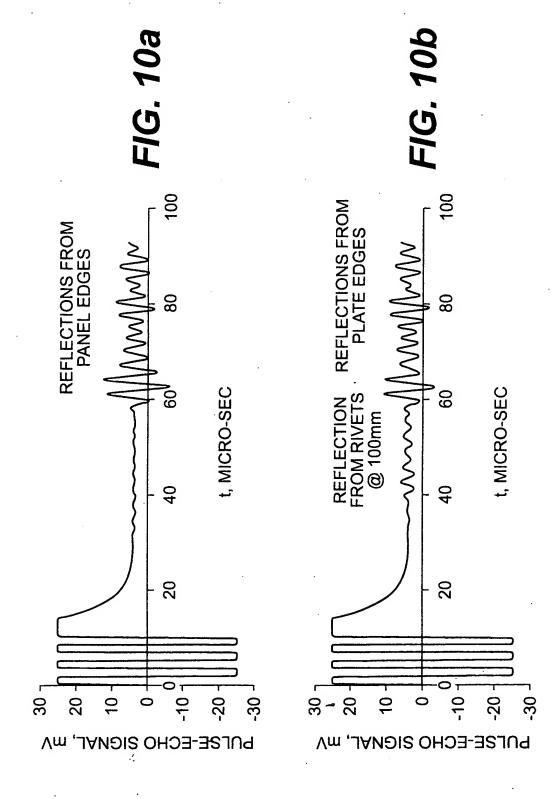


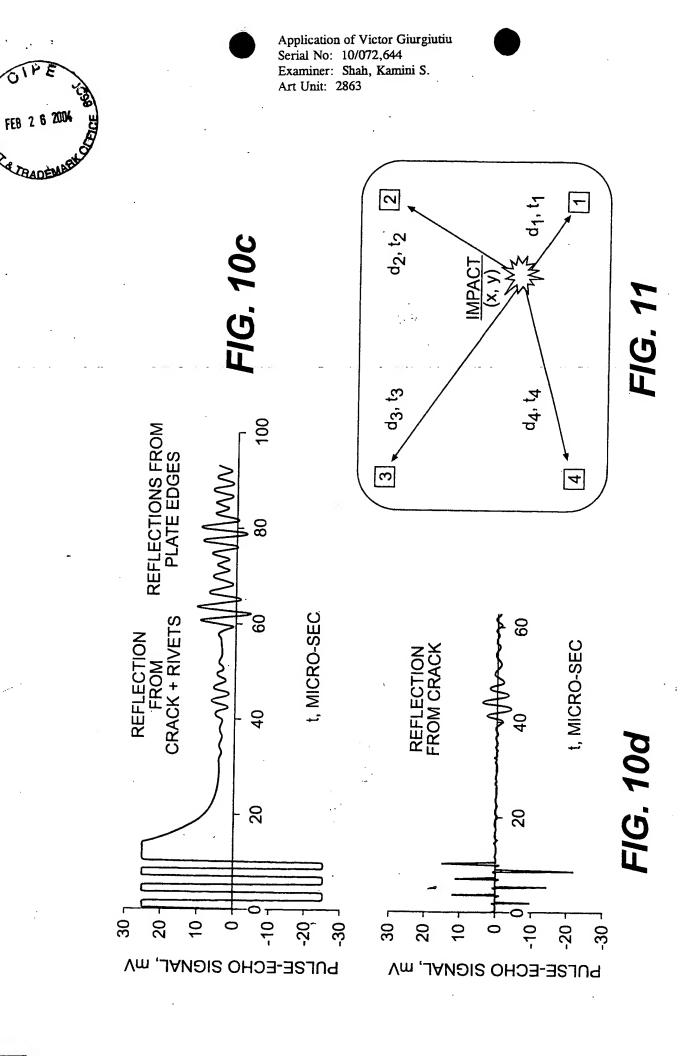
FIG. 9c



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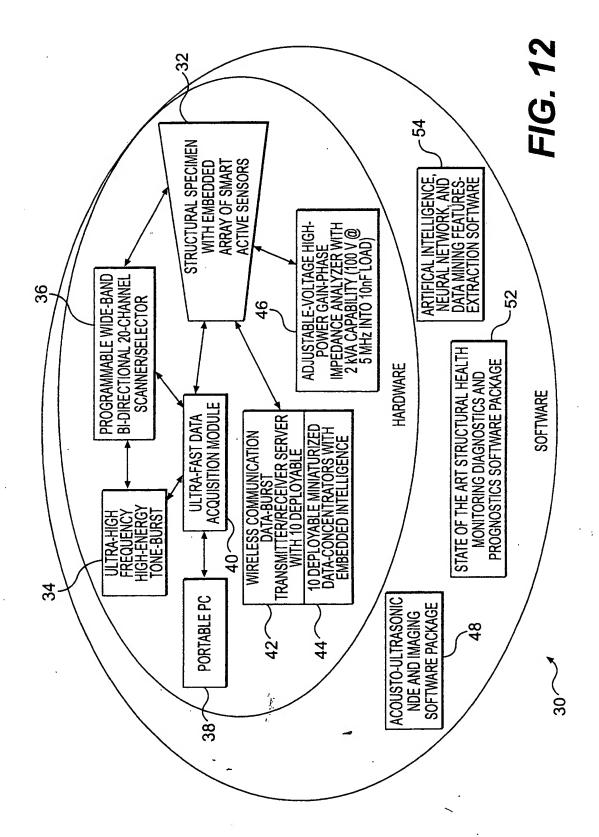
THE TRADE



Application of Victor Giurgiutiu Serial No: 10/072,644

Examiner: Shah, Kamini S.

Art Unit: 2863-





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2. Cover letter w/ first class mail certificate

3. 10 sheets of formal drawings, Figs. 1-12

4. Fee Transmittal for FY 2003

5. Check in the amount of \$588.00

Application of Victor Giurgiutiu

Title: In-Situ Structural Health Monitoring, Diagnostics

And Prognostics System Utilizing Thin Piezoelectric

Sensors

Serial No: 10/072,644 filed: 2-8-02

Our Ref: 16139/09021 Date: September 4, 2003

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